Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/676,728	BEDELL ET AL.
Examiner	Art Unit
A. Dexter Tugbang	3729

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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Text Search: NPL - IEEE Xplore Database	6/25/2007	ADT		
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